ILI for Corrosion, Cracks, Stress

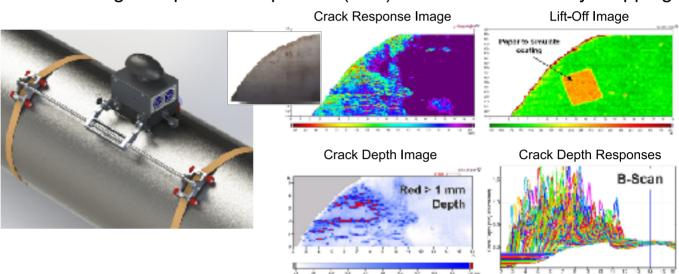
Pipeline In-Line Inspection (ILI)

Rapid, high-resolution imaging of internal corrosion, internal initiated cracks and longitudinal stresses is provided using MWM®-Array technology.

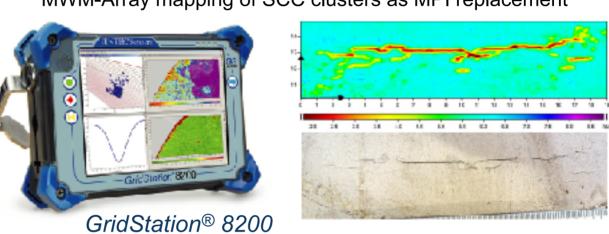


NDT for SCC

MWM®-Array flexible eddy current sensing provides a reliable alternative to magnetic particle inspection (MPI) for SCC crack colony mapping.

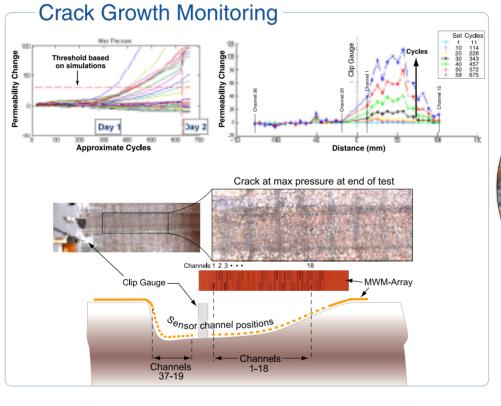


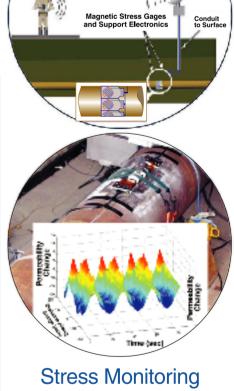
MWM-Array mapping of SCC clusters as MPI replacement



Structural Health Monitoring (SHM)

JENTEK Sensors offers a unique product line for monitoring stress and damage (fatigue, corrosion, and thermo-mechanical damage) through coatings and insulation – suitable for piping, pipelines, vessels and complex oil and gas industry components.





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